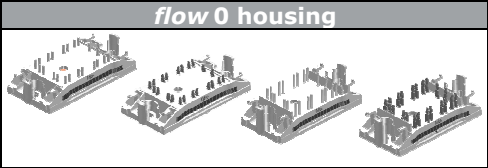
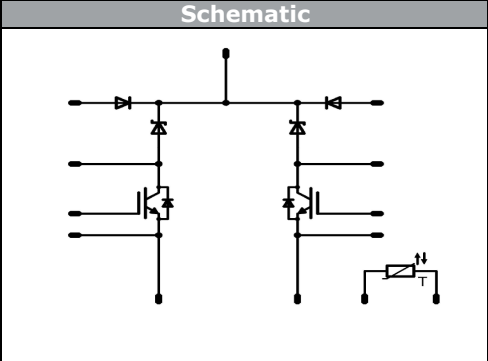




<i>flow BOOST 0</i>	1200 V / 40 A
<div style="background-color: #eee; padding: 2px; margin-bottom: 5px;"><b>Features</b></div> <ul style="list-style-type: none"> <li>High efficiency dual boost</li> <li>Ultra fast switching frequency</li> <li>Low Inductance Layout</li> <li>1200V IGBT and 1200V SiC diode</li> </ul>	<div style="background-color: #eee; padding: 2px; margin-bottom: 5px;"><b>flow 0 housing</b></div> 
<div style="background-color: #eee; padding: 2px; margin-bottom: 5px;"><b>Target Applications</b></div> <ul style="list-style-type: none"> <li>solar inverter</li> </ul>	<div style="background-color: #eee; padding: 2px; margin-bottom: 5px;"><b>Schematic</b></div> 
<div style="background-color: #eee; padding: 2px; margin-bottom: 5px;"><b>Types</b></div> <ul style="list-style-type: none"> <li>V23990-P629-L48-PM</li> <li>V23990-P629-L48Y-PM</li> <li>V23990-P629-L49-PM</li> <li>V23990-P629-L49Y-PM</li> </ul>	

## Maximum Ratings

$T_j=25^{\circ}\text{C}$ , unless otherwise specified

Parameter	Symbol	Condition	Value	Unit
<b>Bypass Diode (D7,D8)</b>				
Repetitive peak reverse voltage	$V_{RRM}$		1600	V
Mean forward current	$I_{FAV}$	$T_j=T_{jmax}$ $T_s=80^{\circ}\text{C}$	34	A
Surge (non-repetitive) forward current	$I_{FSM}$	$t_p=10\text{ms}$ $T_j=150^{\circ}\text{C}$	200	A
$I^2t$ -value	$I^2t$		200	$\text{A}^2\text{s}$
Power dissipation	$P_{tot}$	$T_j=T_{jmax}$ $T_s=80^{\circ}\text{C}$	42	W
Maximum Junction Temperature	$T_{jmax}$		150	$^{\circ}\text{C}$
<b>Input Boost IGBT (T1,T2)</b>				
Collector-emitter break down voltage	$V_{CES}$		1200	V
DC collector current	$I_C$	$T_j=T_{jmax}$ $T_s=80^{\circ}\text{C}$	41	A
Pulsed collector current	$I_{CRM}$	$t_p$ limited by $T_{jmax}$	120	A
Turn off safe operating area		$T_j \leq 150^{\circ}\text{C}$ $V_{CE} \leq V_{CES}$	80	A
Power dissipation	$P_{tot}$	$T_j=T_{jmax}$ $T_s=80^{\circ}\text{C}$	113	W
Gate-emitter peak voltage	$V_{GE}$		$\pm 20$	V
Short circuit ratings	$t_{SC}$ $V_{CC}$	$T_j \leq 150^{\circ}\text{C}$ $V_{GE} = 15\text{V}$	10 800	$\mu\text{s}$ V
Maximum Junction Temperature	$T_{jmax}$		175	$^{\circ}\text{C}$



## Maximum Ratings

$T_j=25^{\circ}\text{C}$ , unless otherwise specified

Parameter	Symbol	Condition	Value	Unit
<b>Input Boost FWD (D1,D2,D4,D5)</b>				
Peak Repetitive Reverse Voltage	$V_{RRM}$		1200	V
Mean forward current	$I_{FAV}$	$T_j=T_{jmax}$ $T_s=80^{\circ}\text{C}$	18	A
Surge (non-repetitive) forward current	$I_{FSM}$	$t_p=10\text{ms}$ $T_j=25^{\circ}\text{C}$	92	A
Repetitive peak forward current	$I_{FRM}$	Half Sine Wave $T_j=25^{\circ}\text{C}$	52	A
Power dissipation	$P_{tot}$	$T_j=T_{jmax}$ $T_s=80^{\circ}\text{C}$	50	W
Maximum Junction Temperature	$T_{jmax}$		175	$^{\circ}\text{C}$

### Input Boost Inv. Diode (D9,D10)

Peak Repetitive Reverse Voltage	$V_{RRM}$		1200	V
Mean forward current	$I_{FAV}$	$T_j=T_{jmax}$ $T_s=80^{\circ}\text{C}$	6	A
Repetitive peak forward current	$I_{FRM}$	$t_p$ limited by $T_{jmax}$	6	A
Power dissipation	$P_{tot}$	$T_j=T_{jmax}$ $T_s=80^{\circ}\text{C}$	26	W
Maximum Junction Temperature	$T_{jmax}$		150	$^{\circ}\text{C}$

### Thermal Properties

Storage temperature	$T_{stg}$		-40...+125	$^{\circ}\text{C}$
Operation temperature under switching condition	$T_{op}$		-40...+( $T_{jmax} - 25$ )	$^{\circ}\text{C}$

### Insulation Properties

Insulation voltage		$t=2\text{s}$ DC voltage	4000	V
Creepage distance			min 12,7	mm
Clearance		12mm housing with solder pins	min 9,55	mm
Clearance		12mm housing with pressfit pins	min 9,57	mm
Clearance		17mm housing	min 12,7	mm



Characteristic Values

Parameter	Symbol	Conditions					Value			Unit
		$V_{GE}$ [V] or $V_{GS}$ [V]	$V_r$ [V] or $V_{CE}$ [V] or $V_{DS}$ [V]	$I_C$ [A] or $I_F$ [A] or $I_D$ [A]	$T_j$ [°C]	Min	Typ	Max		

**Bypass Diode (D7,D8)**

Forward voltage	$V_F$				25	25 125	0,7	1,15 1,11	1,4	V
Threshold voltage (for power loss calc. only)	$V_{th}$				25	25 125		0,92 0,82		V
Slope resistance (for power loss calc. only)	$r_t$				25	25 125		0,009 0,012		$\Omega$
Reverse current	$I_r$			1500		25 125			0,05	mA
Thermal resistance junction to sink	$R_{th(j-s)}$	phase-change material $\lambda=3,4W/mK$						1,67		K/W

**Input Boost IGBT (T1,T2)**

Gate emitter threshold voltage	$V_{GE(th)}$		$V_{GE}=V_{CE}$		0,0015	25 150	5,2	5,8	6,4	V
Collector-emitter saturation voltage	$V_{CE(sat)}$		15		40	25 150	1,7	2,1 2,48	2,6	V
Collector-emitter cut-off	$I_{CES}$		0	1200		25 150			0,25	mA
Gate-emitter leakage current	$I_{GES}$		20	0		25 150			120	nA
Integrated Gate resistor	$R_{gint}$							none		$\Omega$
Turn-on delay time	$t_{d(on)}$	$R_{goff}=16 \Omega$ $R_{gon}=16 \Omega$	15	700	40	25		35		ns
Rise time	$t_r$					150		34,2		
Turn-off delay time	$t_{d(off)}$					25		26,4		
Fall time	$t_f$					150		27,2		
Turn-on energy loss	$E_{on}$					25		372,2		
Turn-off energy loss	$E_{off}$	150		430,8		2,061 2,19				mWs
Input capacitance	$C_{ies}$							2360		pF
Output capacitance	$C_{oss}$	f=1MHz	0	25		25		230		
Reverse transfer capacitance	$C_{rss}$							125		
Gate charge	$Q_G$	f=1MHz	0	25	40	25		192		nC
Thermal resistance junction to sink	$R_{th(j-s)}$	phase-change material $\lambda=3,4W/mK$						0,84		K/W

**Input Boost FWD (D1,D2,D4,D5)**

Forward voltage	$V_F$				10	25 150	1	1,46 1,8	2	V
Reverse leakage current	$I_{rm}$			1200		25 150			300	$\mu A$
Peak recovery current	$I_{RRM}$	$R_{goff}=16 \Omega$	15	700	40	25		7,78		A
Reverse recovery time	$t_{rr}$					150		8,1		
Reverse recovery charge	$Q_{rr}$					25		9,5		
Reverse recovered energy	$E_{rec}$					150		0,04 0,04		
Peak rate of fall of recovery current	$(di_{rr}/dt)_{max}$					25		0,002 0,002		
Thermal resistance junction to sink	$R_{th(j-s)}$	phase-change material $\lambda=3,4W/mK$						2480 2790		A/ $\mu s$
Thermal resistance junction to sink	$R_{th(j-s)}$	phase-change material $\lambda=3,4W/mK$						1,88		K/W

**Input Boost Inv. Diode (D9,D10)**

Diode forward voltage	$V_F$				3	25 125		1,65 1,58		V
Thermal resistance junction to sink	$R_{th(j-s)}$	phase-change material $\lambda=3,4W/mK$						2,72		K/W



### Characteristic Values

Parameter	Symbol	Conditions					Value			Unit
		$V_{GE}$ [V] or $V_{GS}$ [V]	$V_r$ [V] or $V_{CE}$ [V] or $V_{DS}$ [V]	$I_C$ [A] or $I_F$ [A] or $I_D$ [A]	$T_j$ [°C]	Min	Typ	Max		

Thermistor										
Rated resistance	$R$					25		21,5		kΩ
Deviation of R100	$\Delta_{R/R}$	$R_{100}=1486 \Omega$				25	-4,5		+4,5	%
Power dissipation	$P$					25		210		mW
Power dissipation constant						25		3,5		mW/K
B-value	B(25/50)					25		3884		K
B-value	B(25/100)					25		3964		K
Vincotech NTC Reference									F	

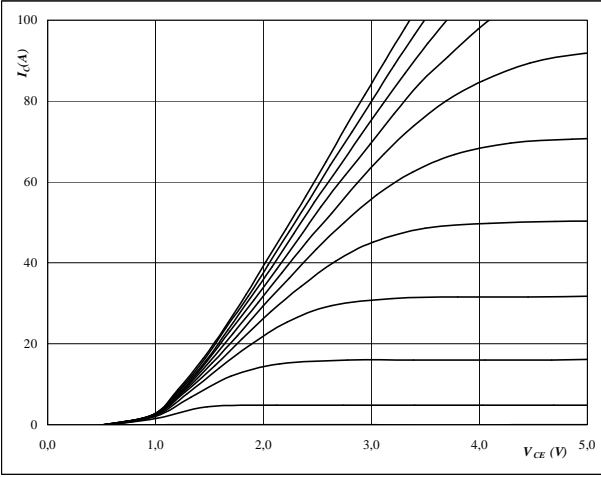


### INPUT BOOST

**Figure 1** BOOST IGBT

**Typical output characteristics**

$I_C = f(V_{CE})$



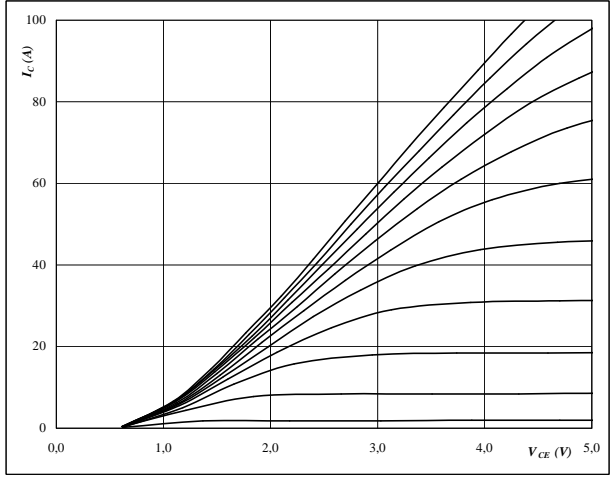
**At**

$t_p = 250 \mu s$   
 $T_j = 25 \text{ } ^\circ C$   
 $V_{GE}$  from 7 V to 17 V in steps of 1 V

**Figure 2** BOOST IGBT

**Typical output characteristics**

$I_C = f(V_{CE})$



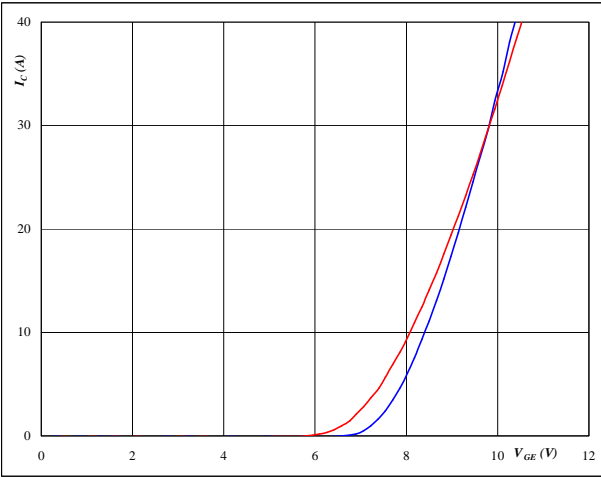
**At**

$t_p = 250 \mu s$   
 $T_j = 125 \text{ } ^\circ C$   
 $V_{GE}$  from 7 V to 17 V in steps of 1 V

**Figure 3** BOOST IGBT

**Typical transfer characteristics**

$I_C = f(V_{GS})$



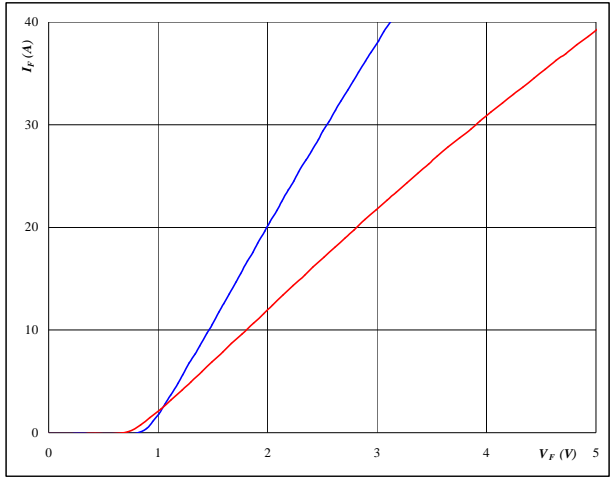
**At**

$t_p = 250 \mu s$   
 $V_{CE} = 10 V$   
 $T_j = 25/125 \text{ } ^\circ C$

**Figure 4** BOOST FWD

**Typical diode forward current as a function of forward voltage**

$I_F = f(V_F)$



**At**

$T_j = 25/125 \text{ } ^\circ C$   
 $t_p = 250 \mu s$

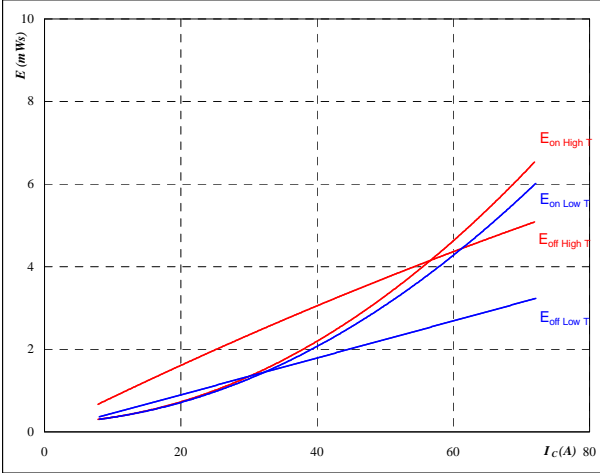


## INPUT BOOST

**Figure 5** BOOST IGBT

Typical switching energy losses  
as a function of collector current

$$E = f(I_C)$$



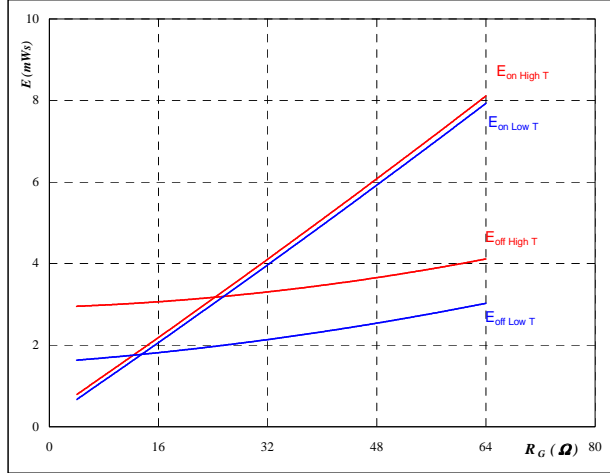
With an inductive load at

$T_j = 25/125$  °C  
 $V_{CE} = 700$  V  
 $V_{GE} = \pm 15$  V  
 $R_{gon} = 16$  Ω  
 $R_{goff} = 16$  Ω

**Figure 6** BOOST IGBT

Typical switching energy losses  
as a function of gate resistor

$$E = f(R_G)$$



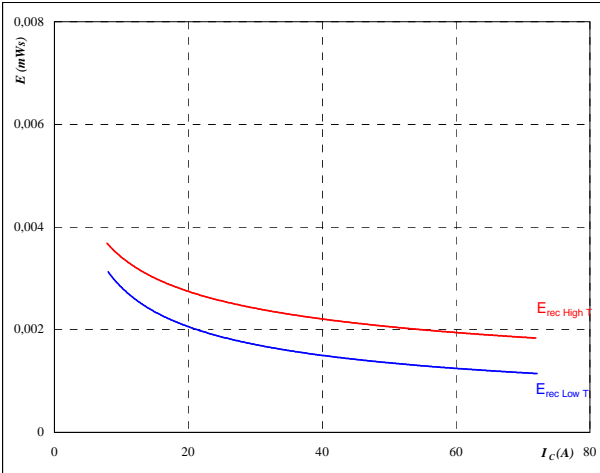
With an inductive load at

$T_j = 25/125$  °C  
 $V_{CE} = 700$  V  
 $V_{GE} = \pm 15$  V  
 $I_D = 40$  A

**Figure 7** BOOST FWD

Typical reverse recovery energy loss  
as a function of collector current

$$E_{rec} = f(I_C)$$



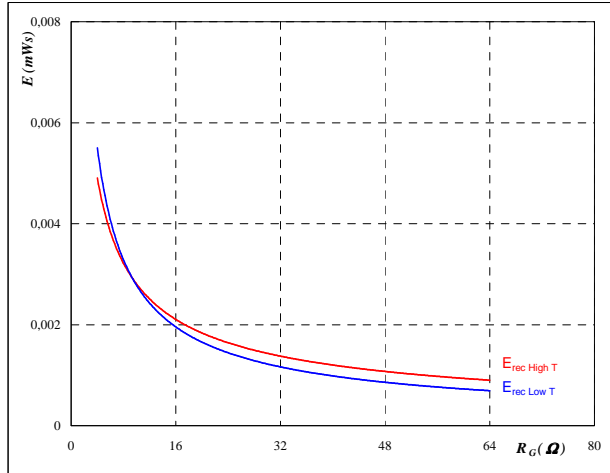
With an inductive load at

$T_j = 25/125$  °C  
 $V_{CE} = 700$  V  
 $V_{GE} = \pm 15$  V  
 $R_{gon} = 16$  Ω  
 $R_{goff} = 16$  Ω

**Figure 8** BOOST FWD

Typical reverse recovery energy loss  
as a function of gate resistor

$$E_{rec} = f(R_G)$$



With an inductive load at

$T_j = 25/125$  °C  
 $V_{CE} = 700$  V  
 $V_{GE} = \pm 15$  V  
 $I_C = 40$  A

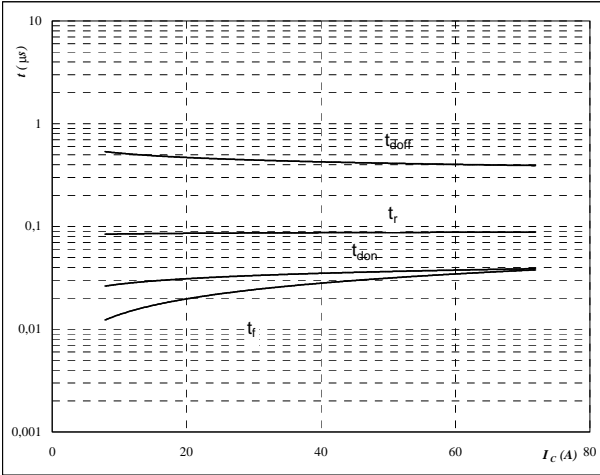


## INPUT BOOST

**Figure 9** BOOST IGBT

Typical switching times as a function of collector current

$$t = f(I_C)$$



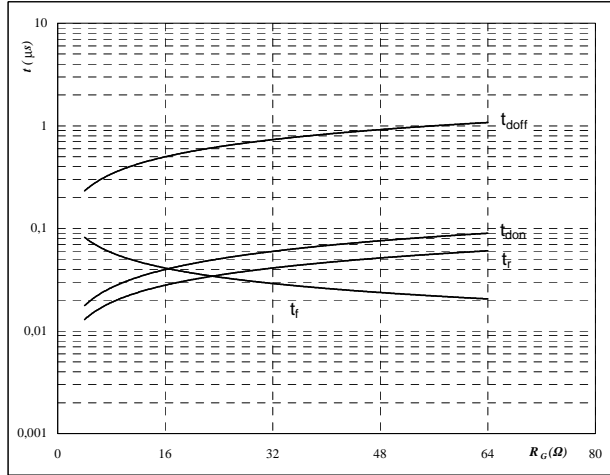
With an inductive load at

$T_j =$	125	°C
$V_{CE} =$	700	V
$V_{GE} =$	±15	V
$R_{gon} =$	16	Ω
$R_{goff} =$	16	Ω

**Figure 10** BOOST IGBT

Typical switching times as a function of gate resistor

$$t = f(R_G)$$



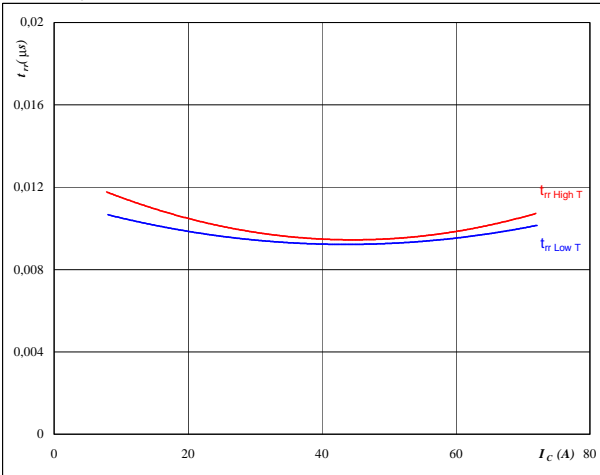
With an inductive load at

$T_j =$	125	°C
$V_{CE} =$	700	V
$V_{GE} =$	±15	V
$I_C =$	40	A

**Figure 11** BOOST FWD

Typical reverse recovery time as a function of collector current

$$t_{rr} = f(I_C)$$



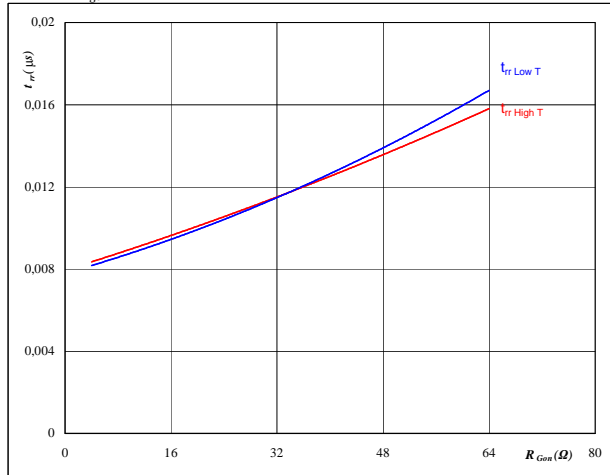
**At**

$T_j =$	25/125	°C
$V_{CE} =$	700	V
$V_{GE} =$	±15	V
$R_{gon} =$	16	Ω

**Figure 12** BOOST FWD

Typical reverse recovery time as a function of IGBT turn on gate resistor

$$t_{rr} = f(R_{gon})$$



**At**

$T_j =$	25/125	°C
$V_R =$	700	V
$I_F =$	40	A
$V_{GE} =$	±15	V

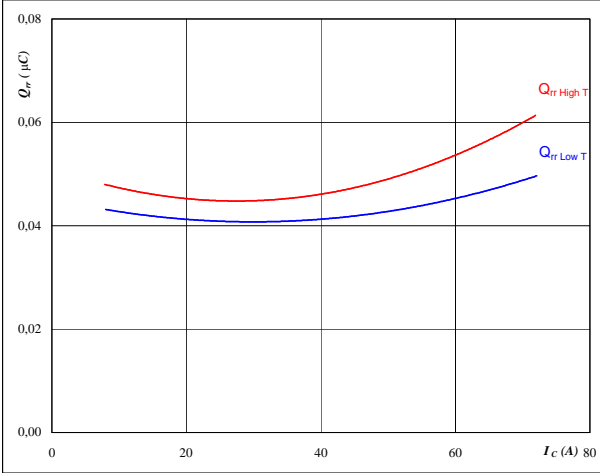


### INPUT BOOST

**Figure 13** BOOST FWD

Typical reverse recovery charge as a function of collector current

$Q_{rr} = f(I_C)$



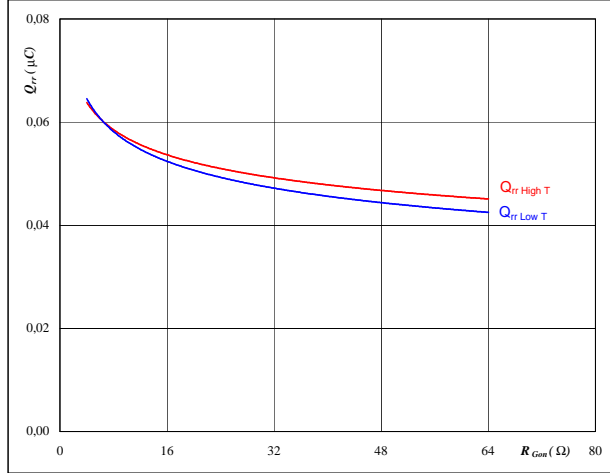
At

$T_j = 25/125$  °C  
 $V_{CE} = 700$  V  
 $V_{GE} = \pm 15$  V  
 $R_{gon} = 16$  Ω

**Figure 14** BOOST FWD

Typical reverse recovery charge as a function of IGBT turn on gate resistor

$Q_{rr} = f(R_{gon})$



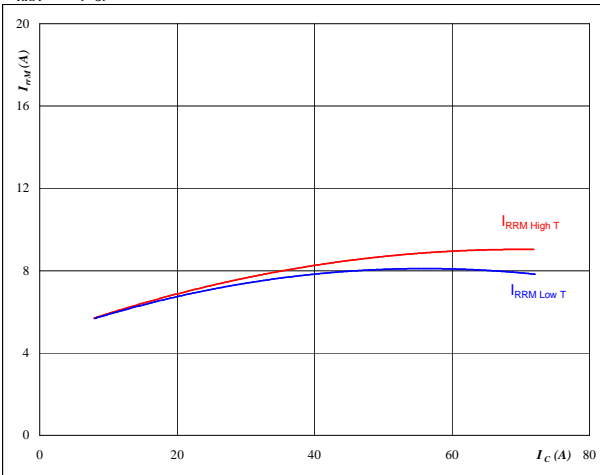
At

$T_j = 25/125$  °C  
 $V_R = 700$  V  
 $I_T = 40$  A  
 $V_{GE} = \pm 15$  V

**Figure 15** BOOST FWD

Typical reverse recovery current as a function of collector current

$I_{RRM} = f(I_C)$



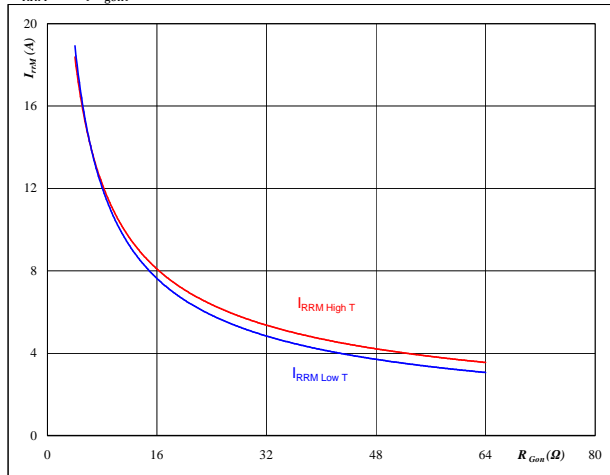
At

$T_j = 25/125$  °C  
 $V_{CE} = 700$  V  
 $V_{GE} = \pm 15$  V  
 $R_{gon} = 16$  Ω

**Figure 16** BOOST FWD

Typical reverse recovery current as a function of IGBT turn on gate resistor

$I_{RRM} = f(R_{gon})$



At

$T_j = 25/125$  °C  
 $V_R = 700$  V  
 $I_F = 40$  A  
 $V_{GE} = \pm 15$  V



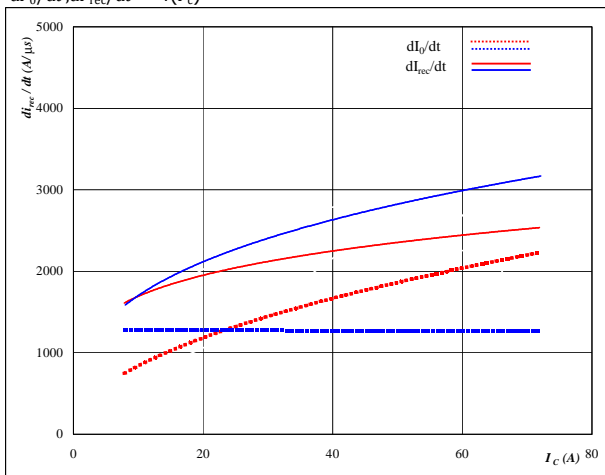


### INPUT BOOST

**Figure 17** BOOST FWD

Typical rate of fall of forward and reverse recovery current as a function of collector current

$$dI_0/dt, dI_{rec}/dt = f(I_c)$$



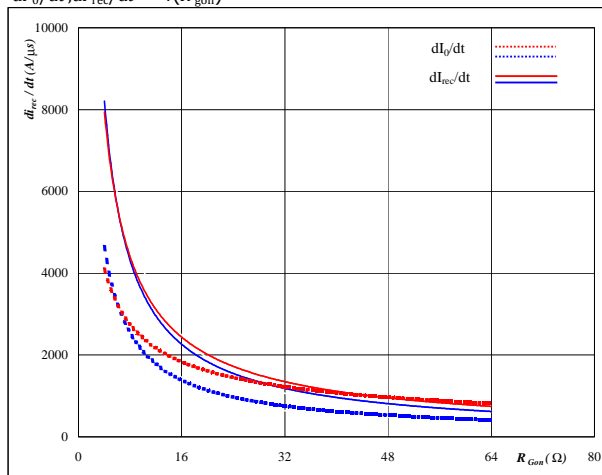
At

$T_j = 25/125$  °C  
 $V_{CE} = 700$  V  
 $V_{GE} = \pm 15$  V  
 $R_{gon} = 16$  Ω

**Figure 18** BOOST FWD

Typical rate of fall of forward and reverse recovery current as a function of IGBT turn on gate resistor

$$dI_0/dt, dI_{rec}/dt = f(R_{gon})$$



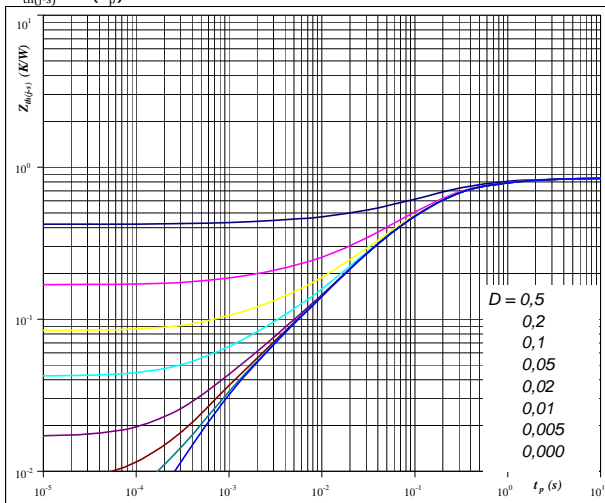
At

$T_j = 25/125$  °C  
 $V_R = 700$  V  
 $I_F = 40$  A  
 $V_{GE} = \pm 15$  V

**Figure 19** BOOST IGBT

IGBT transient thermal impedance as a function of pulse width

$$Z_{th(j-s)} = f(t_p)$$



At

$D = t_p / T$   
 $R_{th(j-s)} = 0,84$  K/W

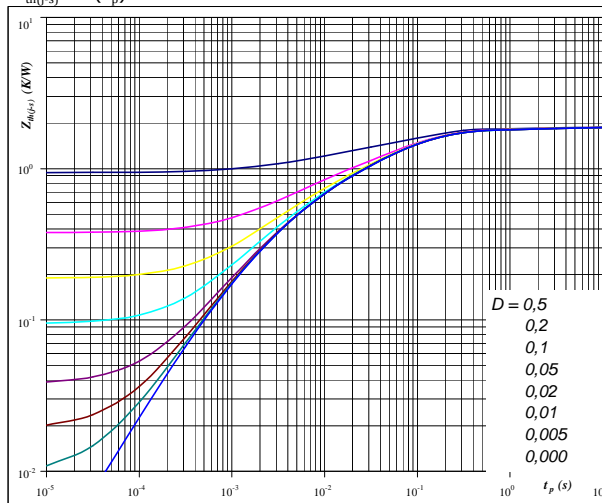
IGBT thermal model values

R (K/W)	τ (s)
1,07E-01	1,41E+00
3,91E-01	1,88E-01
2,23E-01	5,60E-02
9,23E-02	1,12E-02
2,99E-02	1,11E-03

**Figure 20** BOOST FWD

FWD transient thermal impedance as a function of pulse width

$$Z_{th(j-s)} = f(t_p)$$



At

$D = t_p / T$   
 $R_{th(j-s)} = 1,88$  K/W

FWD thermal model values

R (K/W)	τ (s)
5,58E-02	6,96E+00
1,47E-01	5,43E-01
8,94E-01	7,92E-02
4,33E-01	1,33E-02
2,94E-01	3,03E-03
5,99E-02	6,32E-04

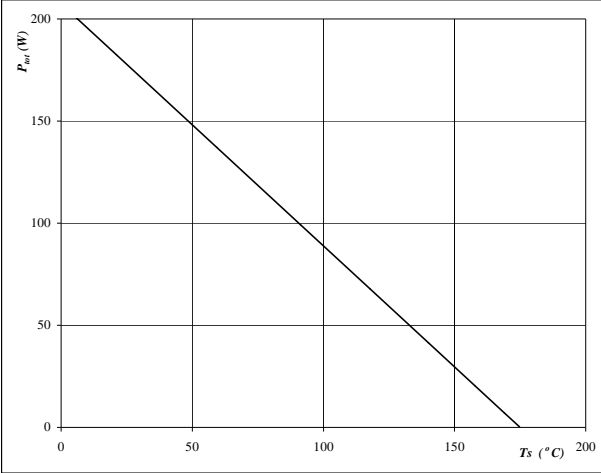


### INPUT BOOST

**Figure 21** BOOST IGBT

**Power dissipation as a function of heatsink temperature**

$$P_{tot} = f(T_s)$$

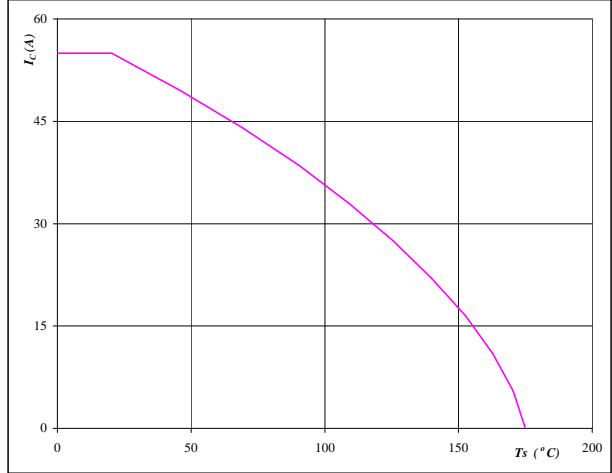


**At**  
 $T_j = 175$  °C

**Figure 22** BOOST IGBT

**Collector current as a function of heatsink temperature**

$$I_c = f(T_s)$$

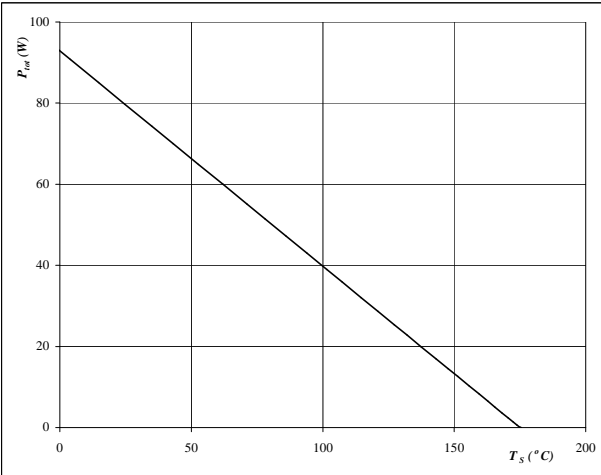


**At**  
 $T_j = 175$  °C  
 $V_{GE} = 15$  V

**Figure 23** BOOST FWD

**Power dissipation as a function of heatsink temperature**

$$P_{tot} = f(T_s)$$

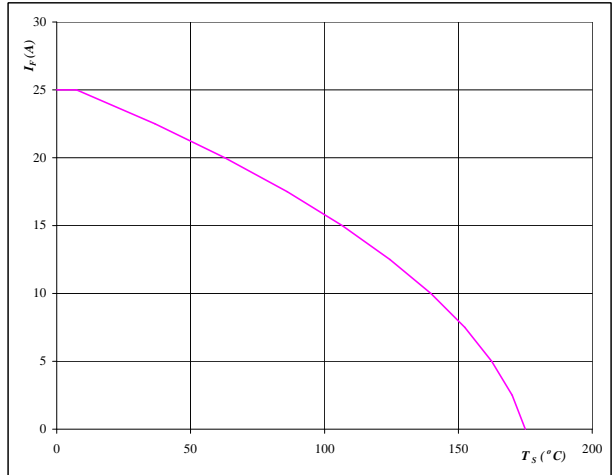


**At**  
 $T_j = 175$  °C

**Figure 24** BOOST FWD

**Forward current as a function of heatsink temperature**

$$I_F = f(T_s)$$



**At**  
 $T_j = 175$  °C

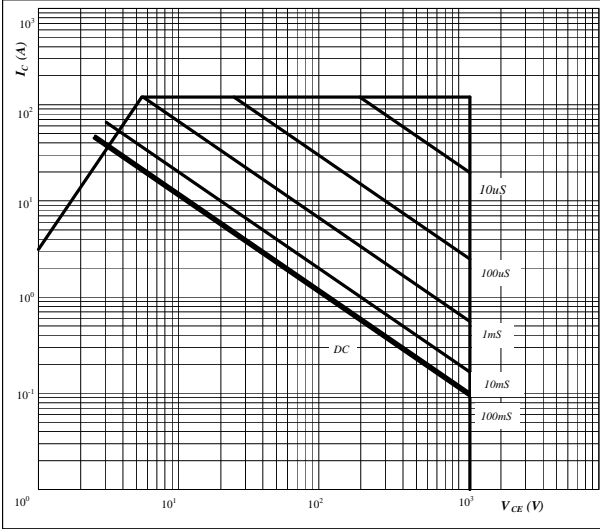


## INPUT BOOST

**Figure 25** BOOST IGBT

Safe operating area as a function of collector-emitter voltage

$$I_C = f(V_{CE})$$

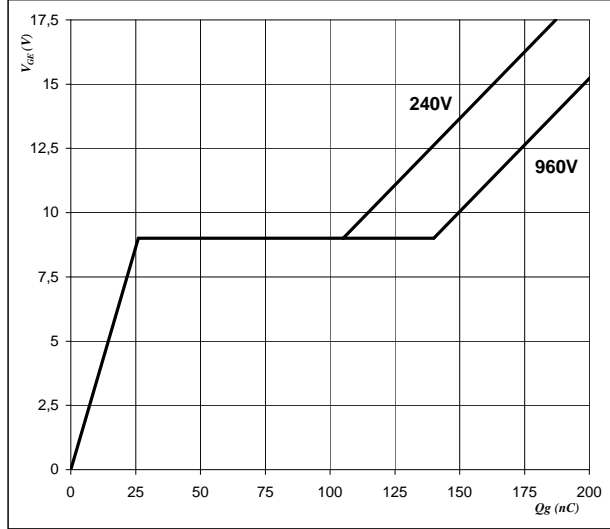


**At**  
 $D =$  single pulse  
 $T_S =$  80 °C  
 $V_{GE} =$  ±15 V  
 $T_j = T_{jmax}$  °C

**Figure 26** BOOST IGBT

Gate voltage vs Gate charge

$$V_{GE} = f(Q_g)$$

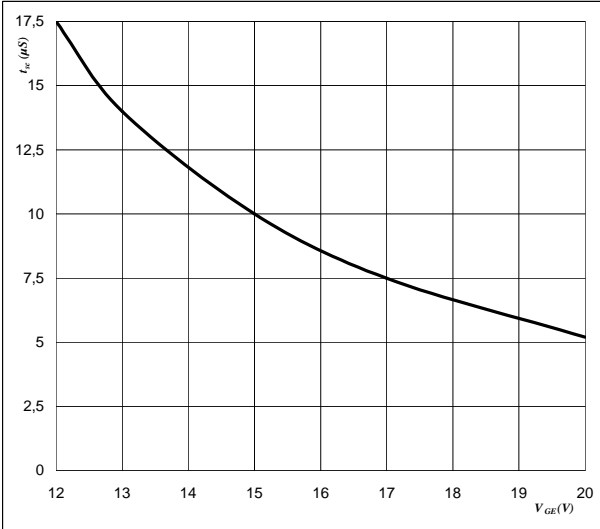


**At**  
 $I_C =$  40 A

**Figure 27** Output inverter IGBT

Short circuit withstand time as a function of gate-emitter voltage

$$t_{sc} = f(V_{GE})$$

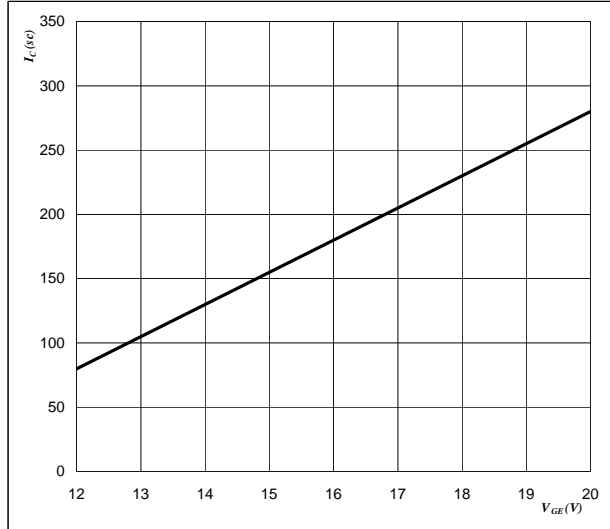


**At**  
 $V_{CE} =$  1200 V  
 $T_j \leq$  150 °C

**Figure 28** Output inverter IGBT

Typical short circuit collector current as a function of gate-emitter voltage

$$V_{GE} = f(Q_{GE})$$

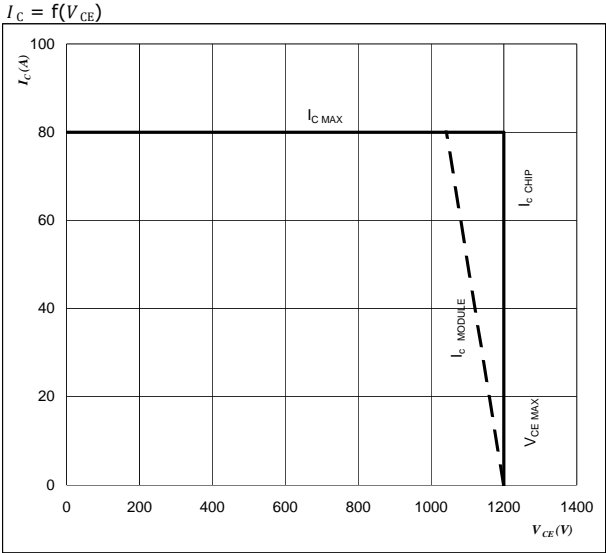


**At**  
 $V_{CE} \leq$  1200 V  
 $T_j =$  150 °C



### INPUT BOOST

**Figure 29** IGBT  
**Reverse bias safe operating area**



**At**

$T_j = T_{j\ max} - 25 \text{ } ^\circ\text{C}$        $R_{gon} = 16 \text{ } \Omega$   
 $R_{goff} = 16 \text{ } \Omega$

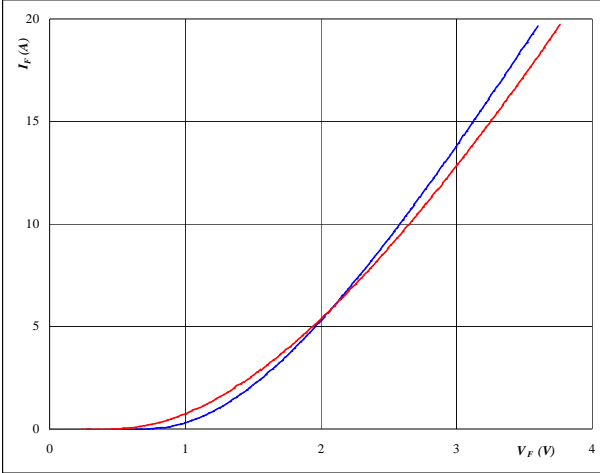


### INPUT BOOST INV. Diode

**Figure 1** INPUT BOOST INV. Diode

Typical diode forward current as a function of forward voltage

$I_F = f(V_F)$

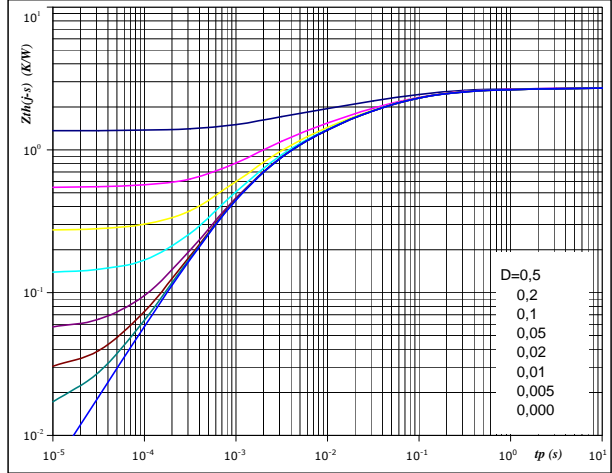


**At**  
 $T_j = 25/125 \text{ } ^\circ\text{C}$   
 $t_p = 250 \text{ } \mu\text{s}$

**Figure 2** INPUT BOOST INV. Diode

Diode transient thermal impedance as a function of pulse width

$Z_{th(j-s)} = f(t_p)$

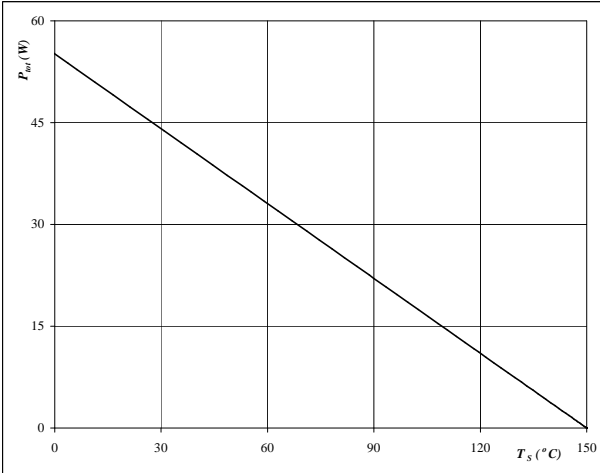


**At**  
 $D = t_p / T$   
 $R_{th(j-s)} = 2,72 \text{ K/W}$

**Figure 3** INPUT BOOST INV. Diode

Power dissipation as a function of heatsink temperature

$P_{tot} = f(T_s)$

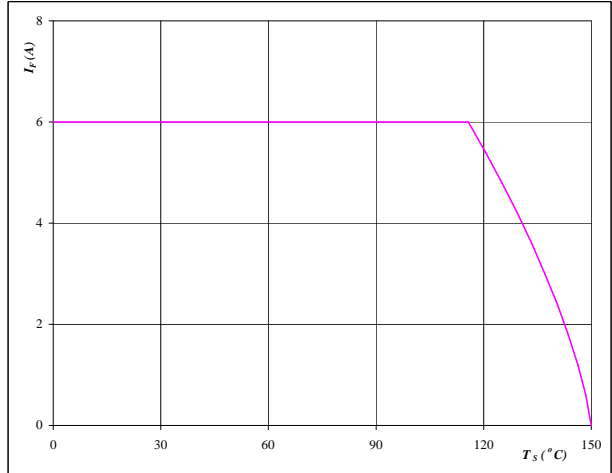


**At**  
 $T_j = 150 \text{ } ^\circ\text{C}$

**Figure 4** INPUT BOOST INV. Diode

Forward current as a function of heatsink temperature

$I_F = f(T_s)$



**At**  
 $T_j = 150 \text{ } ^\circ\text{C}$

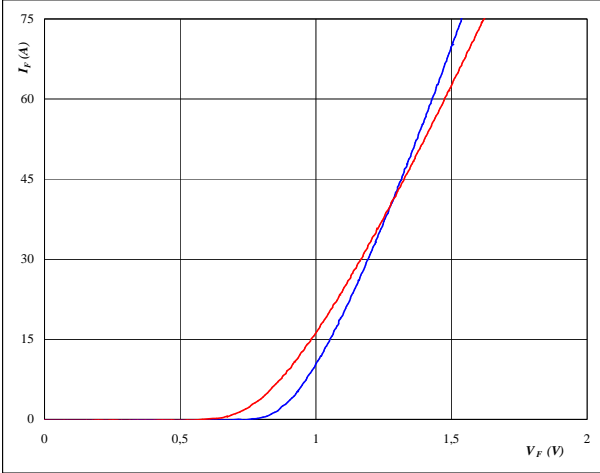


### Bypass Diode

**Figure 1** Bypass diode

Typical diode forward current as a function of forward voltage

$$I_F = f(V_F)$$

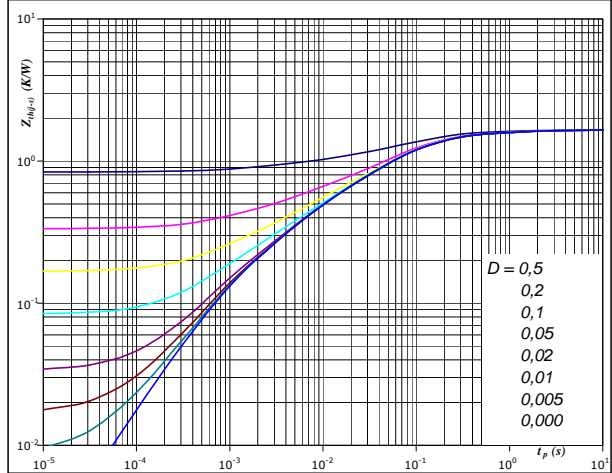


**At**  
 $T_j = 25/125 \text{ } ^\circ\text{C}$   
 $t_p = 250 \text{ } \mu\text{s}$

**Figure 2** Bypass diode

Diode transient thermal impedance as a function of pulse width

$$Z_{th(j-s)} = f(t_p)$$

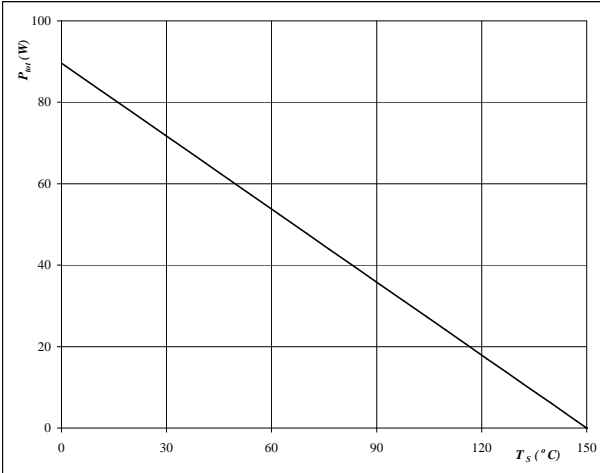


**At**  
 $D = t_p / T$   
 $R_{th(j-s)} = 1,67 \text{ K/W}$

**Figure 3** Bypass diode

Power dissipation as a function of heatsink temperature

$$P_{tot} = f(T_s)$$

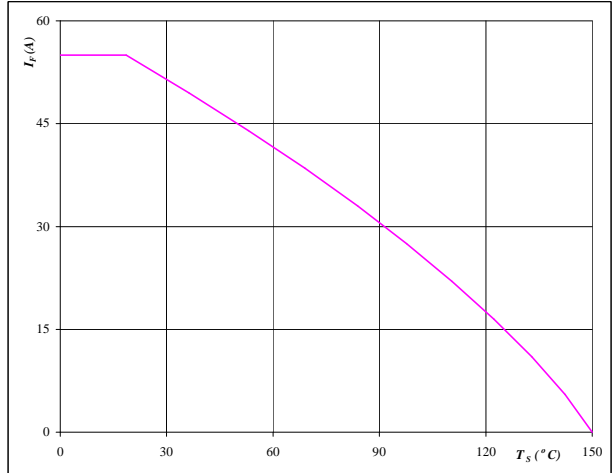


**At**  
 $T_j = 150 \text{ } ^\circ\text{C}$

**Figure 4** Bypass diode

Forward current as a function of heatsink temperature

$$I_F = f(T_s)$$



**At**  
 $T_j = 150 \text{ } ^\circ\text{C}$

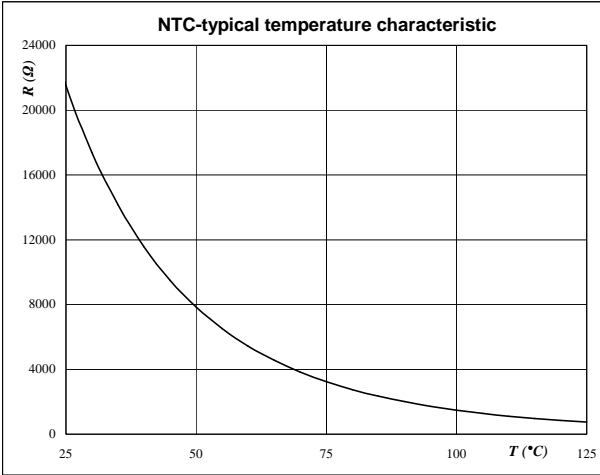


# Thermistor

**Figure 1** Thermistor

**Typical NTC characteristic  
as a function of temperature**

$$R_T = f(T)$$





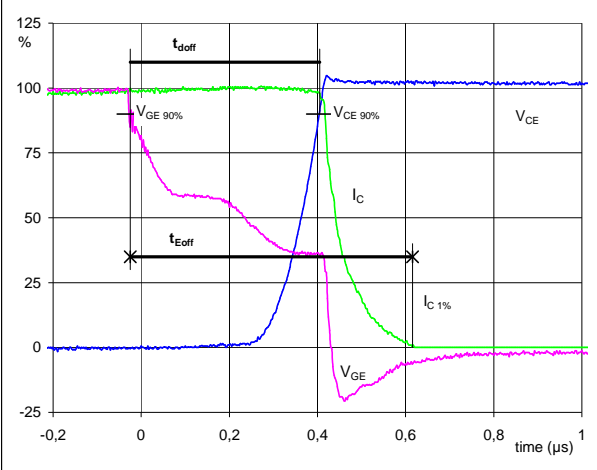
## Switching Definitions

### General conditions

$T_j$	=	125 °C
$R_{gon}$	=	16 $\Omega$
$R_{goff}$	=	16 $\Omega$

**Figure 1** BOOST IGBT

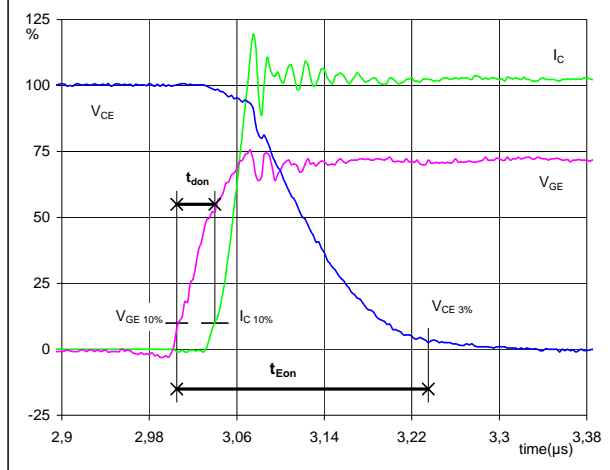
Turn-off Switching Waveforms & definition of  $t_{doff}$ ,  $t_{Eoff}$   
( $t_{Eoff}$  = integrating time for  $E_{off}$ )



$V_{GE}$ (0%) =	0	V
$V_{GE}$ (100%) =	15	V
$V_C$ (100%) =	700	V
$I_C$ (100%) =	40	A
$t_{doff}$ =	0,43	$\mu$ s
$t_{Eoff}$ =	0,64	$\mu$ s

**Figure 2** BOOST IGBT

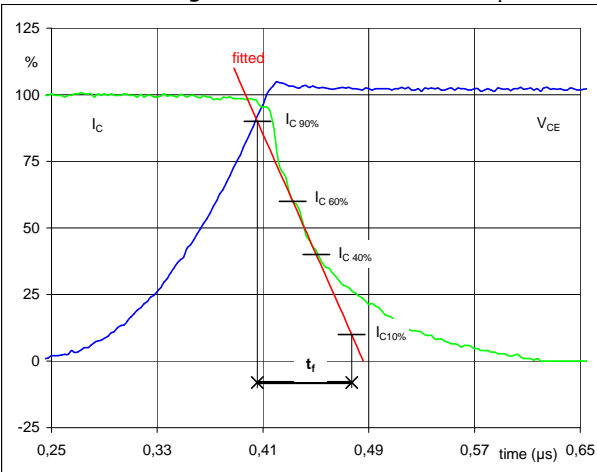
Turn-on Switching Waveforms & definition of  $t_{donr}$ ,  $t_{Eon}$   
( $t_{Eon}$  = integrating time for  $E_{on}$ )



$V_{GE}$ (0%) =	0	V
$V_{GE}$ (100%) =	15	V
$V_C$ (100%) =	700	V
$I_C$ (100%) =	40	A
$t_{donr}$ =	0,034	$\mu$ s
$t_{Eon}$ =	0,230	$\mu$ s

**Figure 3** BOOST IGBT

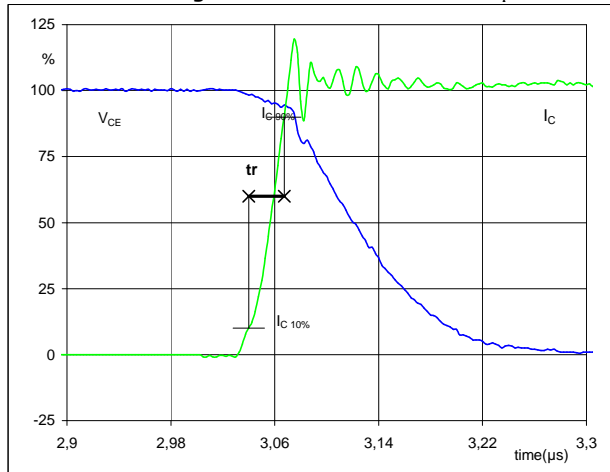
Turn-off Switching Waveforms & definition of  $t_f$



$V_C$ (100%) =	700	V
$I_C$ (100%) =	40	A
$t_f$ =	0,07	$\mu$ s

**Figure 4** BOOST IGBT

Turn-on Switching Waveforms & definition of  $t_r$



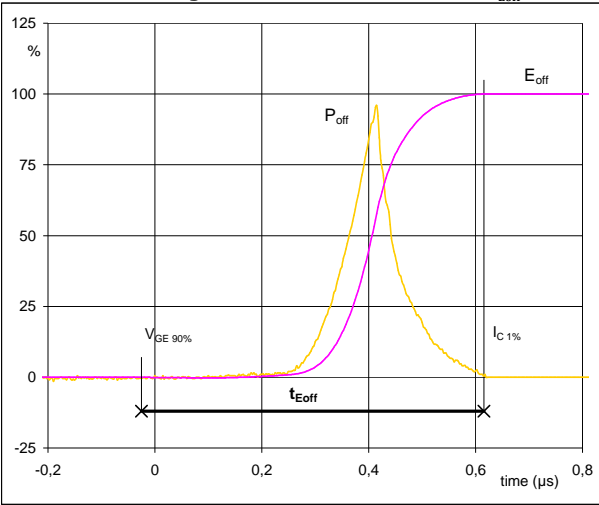
$V_C$ (100%) =	700	V
$I_C$ (100%) =	40	A
$t_r$ =	0,027	$\mu$ s





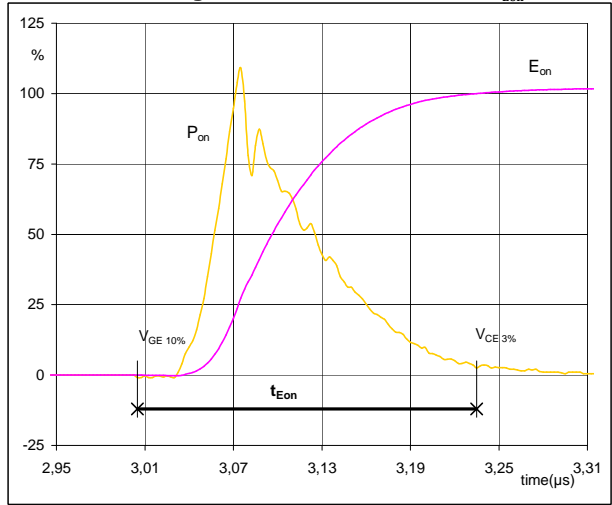
### Switching Definitions

**Figure 5** BOOST IGBT  
Turn-off Switching Waveforms & definition of  $t_{Eoff}$



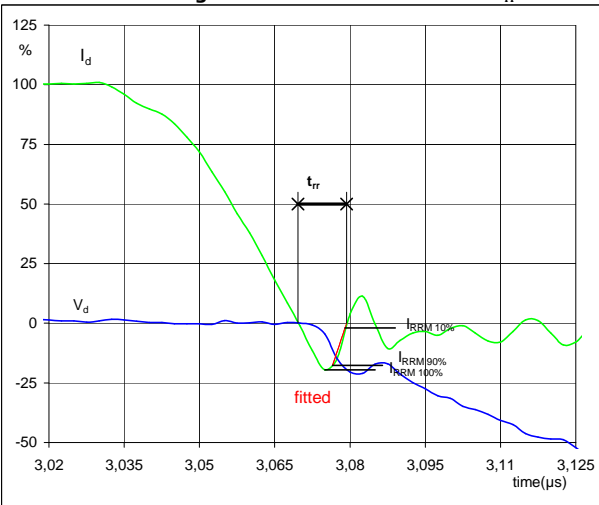
$P_{off} (100\%) = 28,10 \text{ kW}$   
 $E_{off} (100\%) = 3,04 \text{ mJ}$   
 $t_{Eoff} = 0,64 \text{ μs}$

**Figure 6** BOOST IGBT  
Turn-on Switching Waveforms & definition of  $t_{Eon}$



$P_{on} (100\%) = 28,10 \text{ kW}$   
 $E_{on} (100\%) = 2,19 \text{ mJ}$   
 $t_{Eon} = 0,23 \text{ μs}$

**Figure 7** BOOST FWD  
Turn-off Switching Waveforms & definition of  $t_{tr}$



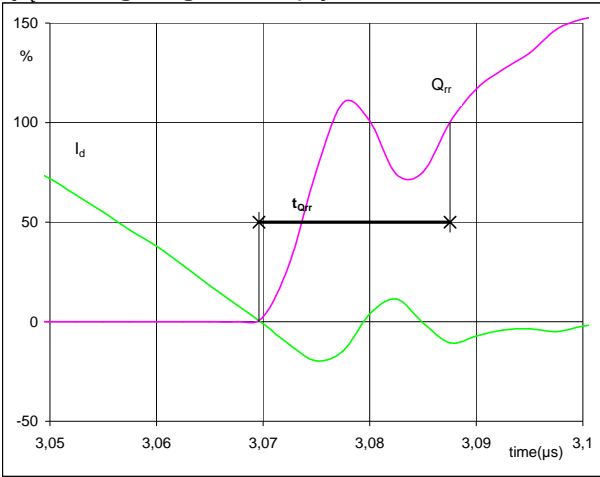
$V_d (100\%) = 700 \text{ V}$   
 $I_d (100\%) = 40 \text{ A}$   
 $I_{RRM} (100\%) = -8 \text{ A}$   
 $t_{tr} = 0,01 \text{ μs}$



### Switching Definitions

**Figure 8** BOOST FWD

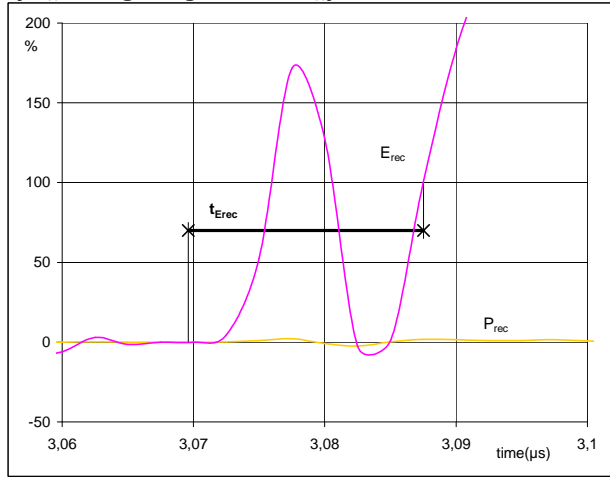
Turn-on Switching Waveforms & definition of  $t_{Q_{rr}}$   
( $t_{Q_{rr}}$  = integrating time for  $Q_{rr}$ )



$I_d$ (100%) =	40	A
$Q_{rr}$ (100%) =	0,04	$\mu\text{C}$
$t_{Q_{rr}}$ =	0,018	$\mu\text{s}$

**Figure 9** BOOST FWD

Turn-on Switching Waveforms & definition of  $t_{E_{rec}}$   
( $t_{E_{rec}}$  = integrating time for  $E_{rec}$ )

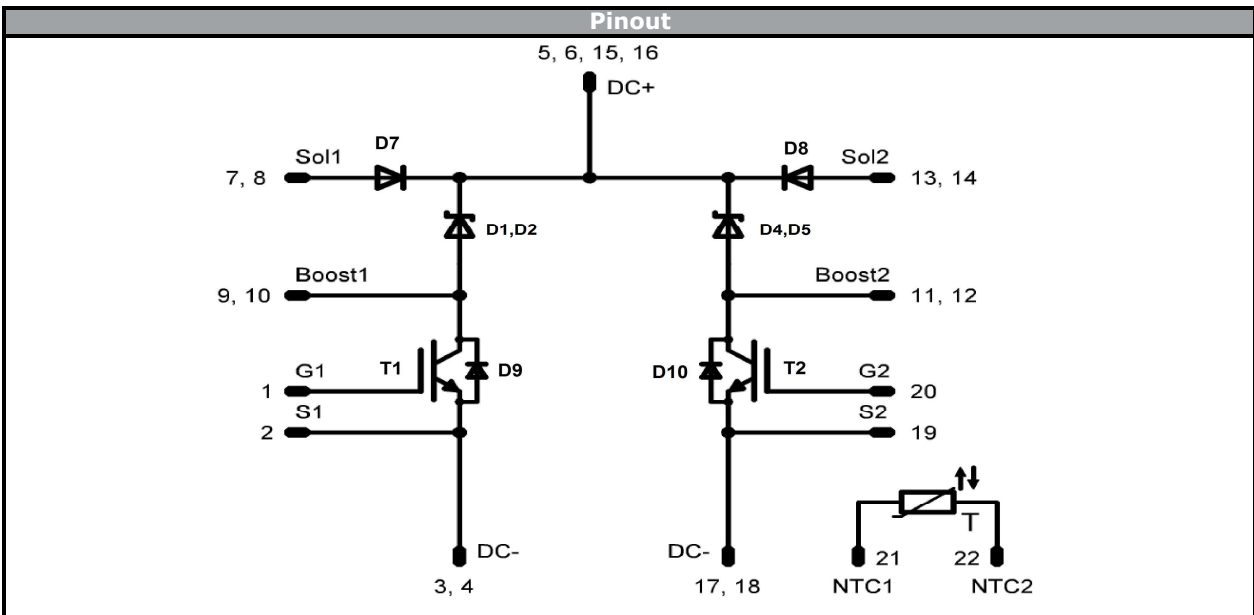
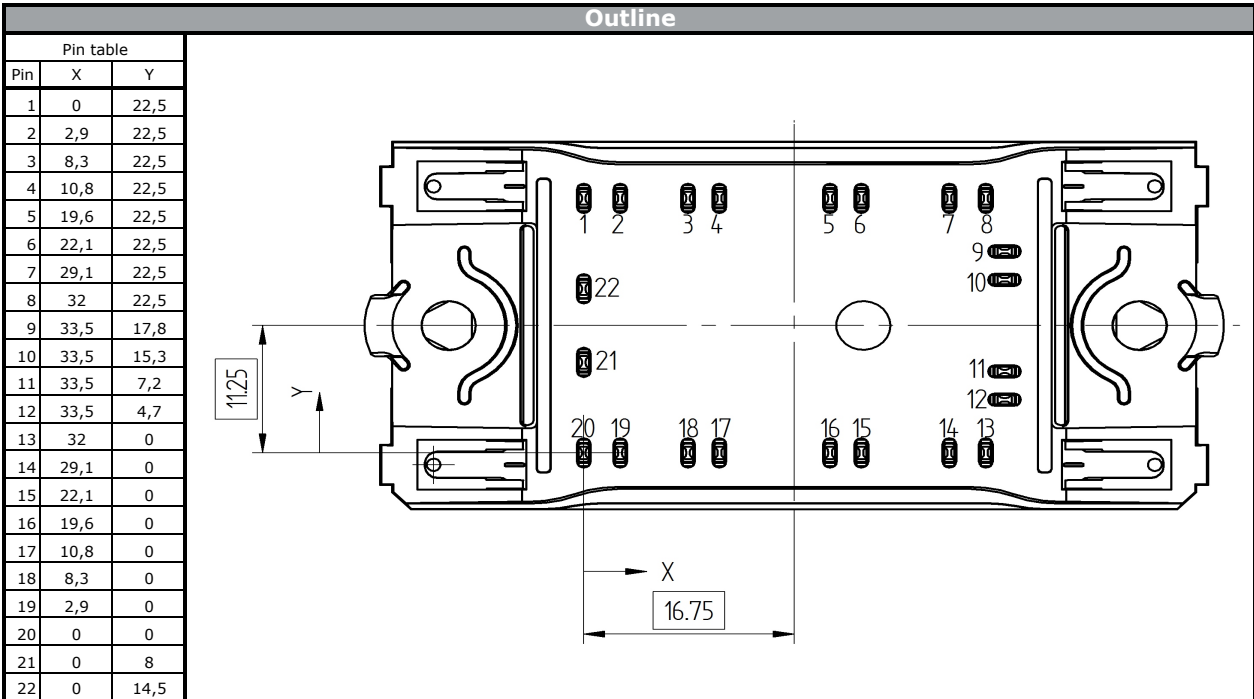


$P_{rec}$ (100%) =	28,10	kW
$E_{rec}$ (100%) =	0,002	mJ
$t_{E_{rec}}$ =	0,018	$\mu\text{s}$



## Ordering Code and Marking - Outline - Pinout

Ordering Code & Marking			
Version	Ordering Code	in DataMatrix as	in packaging barcode as
12mm housing with solder pins	V23990-P629-L48-PM	P629L48	P629L48
12mm housing with pressfit pins	V23990-P629-L48Y-PM	P629L48Y	P629L48Y
17mm housing with solder pins	V23990-P629-L49-PM	P629L49	P629L49
17mm housing with pressfit pins	V23990-P629-L49Y-PM	P629L49Y	P629L49Y



**Packaging instruction**

Standard packaging quantity (SPQ)	<b>135</b>	>SPQ	Standard	<SPQ	Sample
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**Handling instruction**

Handling instructions for *flow* 0 packages see vincotech.com website.

**Package data**

Package data for *flow* 0 packages see vincotech.com website.

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2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.